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Characterization

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VI Bharat Bhushan,Satoshi Kawata,2006-11-07 The first volume in the series was released in January 2004 and the second to fourth volumes in early 2006 The field is now progressing so fast that there is a need for one volume every 12 to 18 months to capture latest developments Volume VI presents 10 chapters on a variety of new and emerging techniques and refinements of SPM applications *Applied Scanning Probe Methods IV* Bharat Bhushan,Harald Fuchs,2006-02-22 Volumes II III and IV examine the physical and technical foundation for recent progress in applied near field scanning probe techniques and build upon the first volume published in early 2004 The field is progressing so fast that there is a need for a second set of volumes to capture the latest developments It constitutes a timely comprehensive overview of SPM applications now that industrial applications span topographic and dynamical surface studies of thin film semiconductors polymers paper ceramics and magnetic and biological materials Volume II introduces scanning probe microscopy including sensor technology Volume III covers the whole range of characterization possibilities using SPM and Volume IV offers chapters on uses in various industrial applications The international perspective offered in these three volumes which belong together contributes further to the evolution of SPM techniques **Applied Scanning Probe Methods XIII** Bharat Bhushan,Harald

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Applied Scanning Probe Methods XII Bharat Bhushan,Harald Fuchs,2008-10-24 Crack initiation and growth are key issues when it comes to the mechanical reliability of microelectronic devices and microelectromechanical systems MEMS Especially in organic electronics where flexible substrates will play a major role these issues will become of utmost importance It is therefore necessary to develop methods which in situ allow the experimental investigation of surface deformation and fracture processes in thin layers at a micro and nanometer scale While scanning electron microscopy SEM might be used it is also associated with some major experimental drawbacks First of all if polymers are investigated they usually have to be coated with a metal layer due to their commonly non conductive nature Additionally they might be damaged by the electron beam of the microscope or the vacuum might cause outgassing of solvents or evaporation of water and thus change material properties Furthermore for all kinds of materials a considerable amount of experimental effort is necessary to build a tensile testing machine that fits into the chamber Therefore a very promising alternative to SEM is based on the use of an atomic force microscope AFM to observe in situ surface deformation processes during straining of a specimen First steps towards this goal were shown in the 1990s in 1 4 but none of these approaches truly was a microtensile test with sample thicknesses in the range of micrometers To the authors knowledge this was shown for the first time by Hild et al in 5 16

Applied Scanning Probe Methods II Bharat Bhushan,Harald Fuchs,2006-02-21 The Nobel Prize of 1986 on Scanning Tunneling Microscopy signaled a new era in imaging The scanning probes emerged as a new instrument for imaging with a precision sufficient to delineate single atoms At first there were two the Scanning Tunneling Microscope or STM and the Atomic Force Microscope or AFM The STM relies on electrons tunneling between tip and sample whereas the AFM depends on the force acting on the tip when it was placed near the sample These were quickly followed by the Magnetic Force Microscope MFM and the Electrostatic Force Microscope EFM The MFM will image a single magnetic bit with features as small as 10nm With the EFM one can monitor the charge of a single electron Prof Paul Hansma at Santa Barbara opened the door even wider when he was able to image biological objects in aqueous environments At this point the

sluice gates were opened and a multitude of different instruments appeared There are significant differences between the Scanning Probe Microscopes or SPM and others such as the Scanning Electron Microscope or SEM The probe microscopes do not require preparation of the sample and they operate in ambient atmosphere whereas the SEM must operate in a vacuum environment and the sample must be cross sectioned to expose the proper surface However the SEM can record 3D image and movies features that are not available with the scanning probes *Scanning Probe Microscopy in Nanoscience and Nanotechnology* Bharat Bhushan, 2016-04-01 This book presents the physical and technical foundation of the state of the art in applied scanning probe techniques It constitutes a comprehensive overview of SPM applications The chapters are written by leading researchers and application scientists *Forces in Scanning Probe Methods* H.-J. Güntherodt, D. Anselmetti, E. Meyer, 2012-12-06 Proceedings of the NATO Advanced Study Institute Schluchsee Germany March 7-18 1994

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